DISCRETE SEMICONDUCTORS

DATA SHEET

BLF522UHF power MOS transistor

Product specification

September 1992





BLF522

FEATURES

- · High power gain
- · Easy power control
- · Gold metallization
- · Good thermal stability
- · Withstands full load mismatch
- Designed for broadband operation.

DESCRIPTION

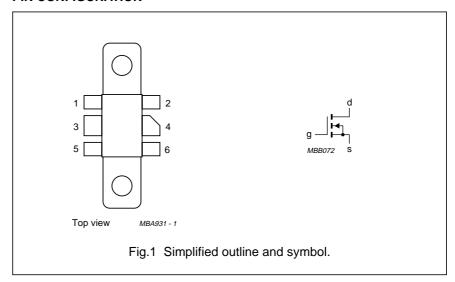
Silicon N-channel enhancement mode vertical D-MOS transistor designed for communications transmitter applications in the UHF frequency range.

The transistor is encapsulated in a 6-lead, SOT171 flange envelope, with a ceramic cap. All leads are isolated from the flange.

PINNING - SOT171

PIN	DESCRIPTION
1	source
2	source
3	gate
4	drain
5	source
6	source

PIN CONFIGURATION



CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static charge during transport and handling.

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

QUICK REFERENCE DATA

RF performance at $T_h = 25$ °C in a common source class-B circuit.

MODE OF OPERATION	f	V _{DS}	P _L	GP	η _D
	(MHz)	(V)	(W)	(dB)	(%)
CW, class-B	500	12.5	5	> 10	> 50

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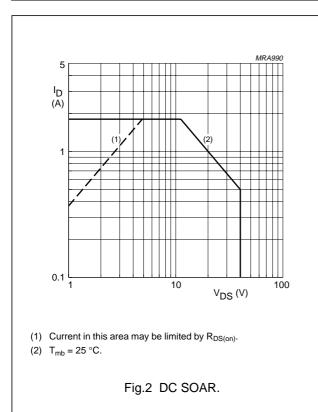
LIMITING VALUES

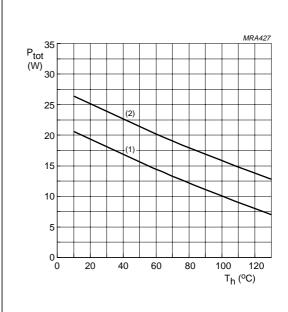
In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	40	V
±V _{GS}	gate-source voltage		_	20	V
I _D	DC drain current		_	1.8	Α
P _{tot}	total power dissipation	up to T _{mb} = 25 °C	_	20	W
T _{stg}	storage temperature		-65	150	°C
Ti	junction temperature		_	200	°C

THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE
R _{th j-mb}	thermal resistance from junction to mounting base	$T_{mb} = 25 ^{\circ}\text{C}; P_{tot} = 20 \text{W}$	8.8 K/W
R _{th mb-h}	thermal resistance from mounting base to heatsink	$T_{mb} = 25 ^{\circ}\text{C}; P_{tot} = 20 \text{W}$	0.4 K/W





- (1) Continuous operation.
- (2) Short-time operation during mismatch.

Fig.3 Power/temperature derating curves.

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CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	V _{GS} = 0; I _D = 5 mA	40	_	_	V
I _{DSS}	drain-source leakage current	V _{GS} = 0; V _{DS} = 12.5 V	_	_	0.5	mA
I _{GSS}	gate-source leakage current	$\pm V_{GS} = 20 \text{ V}; V_{DS} = 0$	_	_	1	μΑ
V _{GS(th)}	gate-source threshold voltage	$I_D = 50 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
9 _{fs}	forward transconductance	$I_D = 0.7 \text{ A}; V_{DS} = 10 \text{ V}$	200	270	_	mS
R _{DS(on)}	drain-source on-state resistance	$I_D = 0.7 \text{ A}; V_{GS} = 15 \text{ V}$	_	1.8	2.7	Ω
I _{DSX}	on-state drain current	V _{GS} = 15 V; V _{DS} = 10 V	_	2.3	_	Α
C _{is}	input capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	-	14	_	pF
C _{os}	output capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	_	17	_	pF
C _{rs}	feedback capacitance	V _{GS} = 0; V _{DS} = 12.5 V; f = 1 MHz	_	3	_	pF

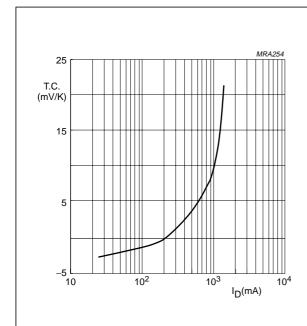
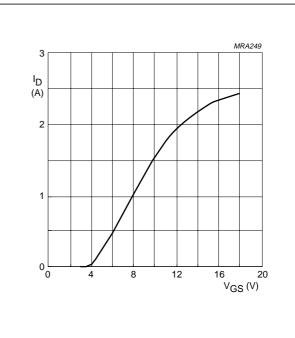


Fig.4 Temperature coefficient of gate-source voltage as a function of drain current, typical values.

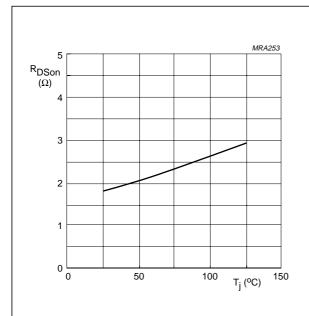


 V_{DS} = 10 V; T_j = 25 °C.

Fig.5 Drain current as a function of gate-source voltage, typical values.

 $V_{DS} = 10 \text{ V}.$

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 $I_D = 0.7 A$; $V_{GS} = 15 V$;

Fig.6 Drain-source on-state resistance as a function of junction temperature, typical values.

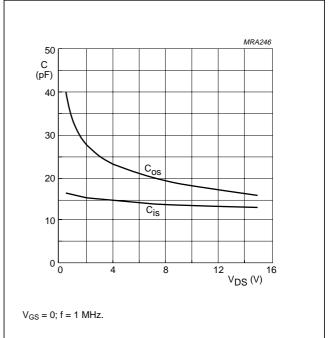
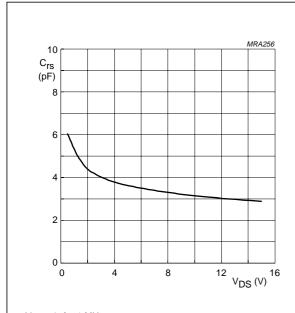


Fig.7 Input and output capacitance as functions of drain-source voltage, typical values.



 $V_{GS} = 0$; f = 1 MHz.

Fig.8 Feedback capacitance as a function of drain-source voltage, typical values.

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APPLICATION INFORMATION FOR CLASS-B OPERATION

 T_h = 25 °C; $R_{th\ mb-h}$ = 0.4 K/W, unless otherwise specified. RF performance in a common source class-B circuit.

MODE OF OPERATION	f (MHz)	V _{DS} (V)	I _{DQ} (mA)	P _L (W)	G _p (dB)	η _D (%)
CW, class-B	500	12.5	50	5	> 10	> 50
					typ. 11	typ. 55

Ruggedness in class-B operation

The BLF522 is capable of withstanding a full load mismatch corresponding to VSWR = 50:1 through all phases under the following conditions:

 V_{DS} = 15.5 V; f = 500 MHz at rated output power.

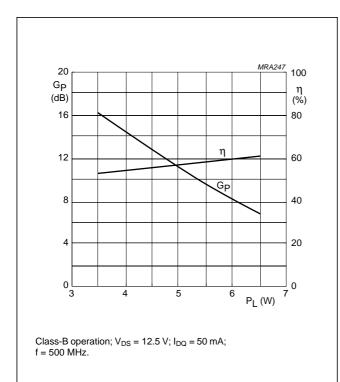


Fig.9 Power gain and efficiency as functions of load power, typical values.

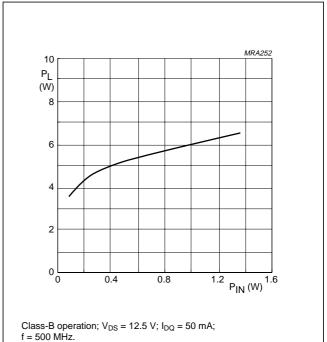
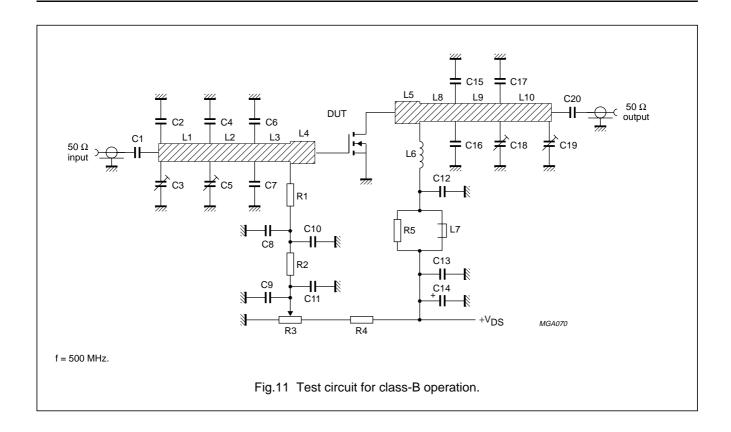


Fig.10 Load power as a function of input power, typical values.

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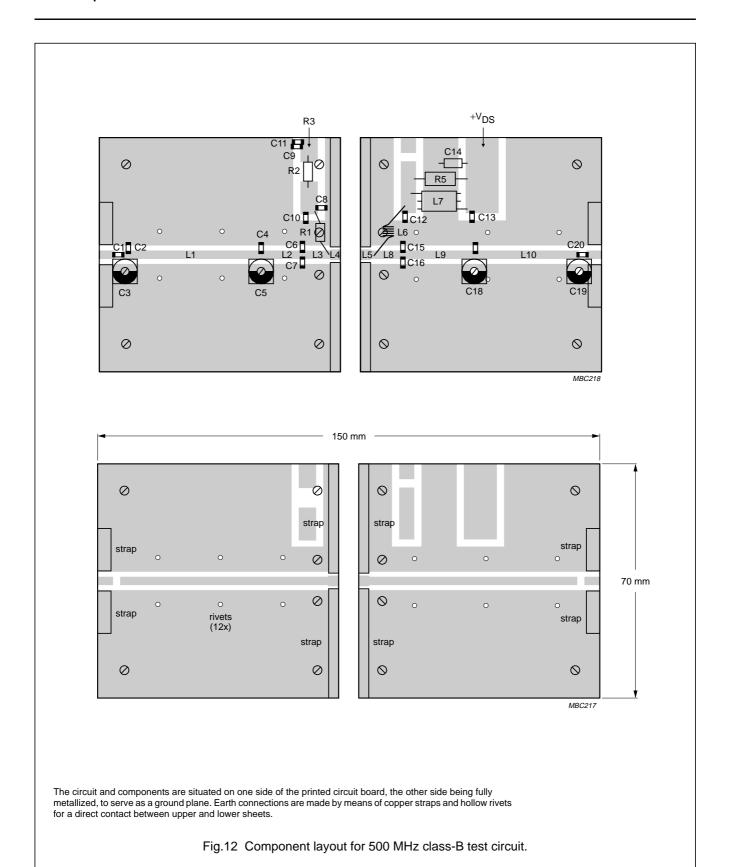
List of components (class-B test circuit)

COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C8, C20	multilayer ceramic chip capacitor (note 1)	430 pF, 50 V		
C2	multilayer ceramic chip capacitor (note 2)	3.9 pF, 50 V		
C3, C5, C18, C19	film dielectric trimmer	2 to 18 pF		2222 809 09003
C4	multilayer ceramic chip capacitor (note 2)	20 pF, 50 V		
C6, C7, C15, C16, C17	multilayer ceramic chip capacitor (note 2)	10 pF, 50 V		
C9, C10, C11, C13	multilayer ceramic chip capacitor	100 nF, 50 V		2222 852 47104
C12	multilayer ceramic chip capacitor (note 1)	390 pF, 50 V		
C14	electrolytic capacitor	10 μF, 63 V		2222 030 38109
L1	stripline (note 3)	50 Ω	36.6 × 2.5 mm	
L2	stripline (note 3)	50 Ω	16.7 × 2.5 mm	
L3	stripline (note 3)	50 Ω	7.7 × 2.5 mm	
L4, L5	stripline (note 3)	42 Ω	3 × 3 mm	
L6	4 turns enamelled 0.8 mm copper wire	24.9 nH	length 6.9 mm int. dia. 2.5 mm leads 2 × 5 mm	
L7	grade 3B Ferroxcube RF choke			4312 020 36642
L8	stripline (note 3)	50 Ω	10 × 2.5 mm	
L9	stripline (note 3)	50 Ω	16.5 × 2.5 mm	
L10	stripline (note 3)	50 Ω	$34.5 \times 2.5 \text{ mm}$	
R1	0.4 W metal film resistor	10 kΩ		2322 151 51003
R2	0.4 W metal film resistor	1 kΩ		2322 151 51002
R3	10 turns cermet potentiometer	50 kΩ		
R4	0.4 W metal film resistor	47 kΩ		2322 151 54703
R5	1 W metal film resistor	10 Ω		2322 153 51009

Notes

- 1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.
- 2. American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
- 3. The striplines are on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric (ε_r = 2.2); thickness 0.79 mm.

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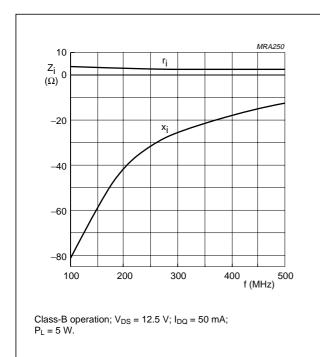


Fig.13 Input impedance as a function of frequency (series components), typical values.

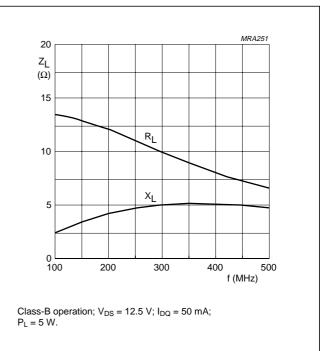
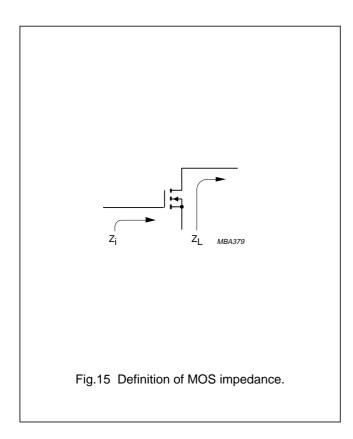
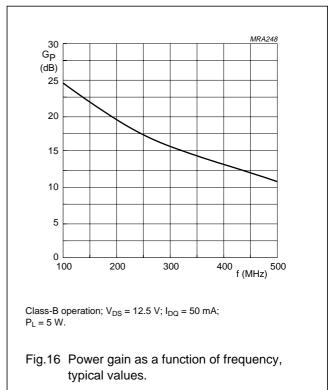


Fig.14 Load impedance as a function of frequency (series components), typical values.



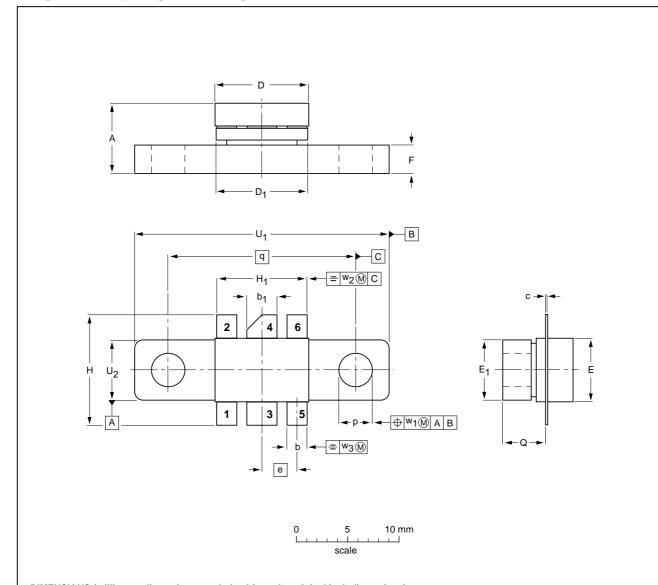


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PACKAGE OUTLINE

Flanged ceramic package; 2 mounting holes; 6 leads

SOT171A



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	Α	b	b ₁	C	D	D ₁	Е	E ₁	е	F	Н	Н ₁	р	Q	q	U ₁	U ₂	w ₁	w ₂	w ₃
mm	6.81 6.07	2.15 1.85	3.20 2.89	0.16 0.07	9.25 9.04	9.30 8.99	5.95 5.74	6.00 5.70	3.58	3.05 2.54	11.31 10.54		3.43 3.17	4.32 4.11	18.42	24.90 24.63		0.51	1.02	0.26
	0.268 0.239							0.236 0.224	0.140	0.120 0.100	0.445 0.415	0.365 0.355	0.135 0.125	0.170 0.162	0.725	0.980 0.970	0.236 0.224	0.02	0.04	0.01

OUTLINE		REFER	EUROPEAN ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT171A						97-06-28

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DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

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